

# Silicon Carbide (SiC) MOSFET – EliteSiC, 40 mohm, 1200 V, M3S, TO-247-4L NTH4L040N120M3S

## Features

- Typ.  $R_{DS(on)} = 40\text{ m}\Omega @ V_{GS} = 18\text{ V}$
- Ultra Low Gate Charge ( $Q_{G(tot)} = 75\text{ nC}$ )
- High Speed Switching with Low Capacitance ( $C_{oss} = 80\text{ pF}$ )
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

## Typical Applications

- Solar Inverters
- Electric Vehicle Charging Stations
- UPS (Uninterruptible Power Supplies)
- Energy Storage Systems
- SMPS (Switch Mode Power Supplies)

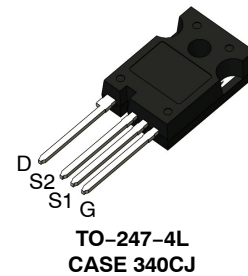
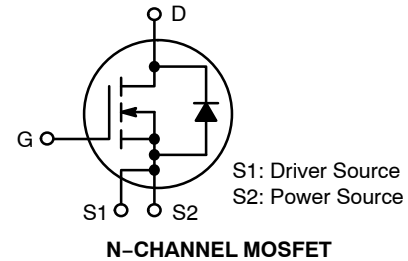
## MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit		
Drain-to-Source Voltage	$V_{DSS}$	1200	V		
Gate-to-Source Voltage	$V_{GS}$	-10/+22	V		
Recommended Operation Values of Gate-to-Source Voltage	$T_C < 175^\circ\text{C}$	$V_{GSop}$	-3/+18 V		
Continuous Drain Current (Notes 1, 3)	Steady State	$T_C = 25^\circ\text{C}$	$I_D$	54	A
			$P_D$	231	W
Power Dissipation (Note 1)	Steady State	$T_C = 100^\circ\text{C}$	$I_D$	38	A
			$P_D$	115	W
Pulsed Drain Current (Note 2)	$T_C = 25^\circ\text{C}$	$I_{DM}$	134	A	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to +175	$^\circ\text{C}$		
Source Current (Body Diode) $T_C = 25^\circ\text{C}, V_{GS} = -3\text{ V}$	$I_S$	45	A		
Single Pulse Drain-to-Source Avalanche Energy (Note 4)	$E_{AS}$	143	mJ		
Maximum Lead Temperature for Soldering (1/25" from case for 10 s)	$T_L$	270	$^\circ\text{C}$		

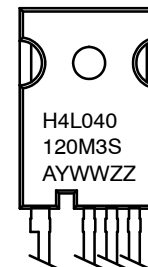
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. Repetitive rating, limited by max junction temperature.
3. The maximum current rating is based on typical  $R_{DS(on)}$  performance.
4. EAS of 143 mJ is based on starting  $T_J = 25^\circ\text{C}$ ;  $L = 1\text{ mH}$ ,  $I_{AS} = 16.9\text{ A}$ ,  $V_{DD} = 100\text{ V}$ ,  $V_{GS} = 18\text{ V}$ .

$V_{(BR)DSS}$	$R_{DS(ON)}\text{ MAX}$	$I_D\text{ MAX}$
1200 V	54 m $\Omega$ @ 18 V	54 A



## MARKING DIAGRAM



H4L040120M3S = Specific Device Code  
A = Assembly Location  
Y = Year  
WW = Work Week  
ZZ = Lot Traceability

## ORDERING INFORMATION

Device	Package	Shipping
NTH4L040N120M3S	TO-247-4L	30 Units / Tube

# NTH4L040N120M3S

**Table 1. THERMAL CHARACTERISTICS**

Parameter	Symbol	Max	Unit
Junction-to-Case – Steady State (Note 1)	$R_{\theta JC}$	0.65	°C/W
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	40	

**Table 2. ELECTRICAL CHARACTERISTICS** ( $T_J = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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**OFF-STATE CHARACTERISTICS**

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	1200	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	$I_D = 1\text{ mA}$ , referenced to $25^\circ\text{C}$ (Note 6)	-	0.3	-	V/°C
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{GS} = 0\text{ V}, V_{DS} = 1200\text{ V}, T_J = 25^\circ\text{C}$	-	-	100	$\mu\text{A}$
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{GS} = +22/-10\text{ V}, V_{DS} = 0\text{ V}$	-	-	$\pm 1$	$\mu\text{A}$

**ON-STATE CHARACTERISTICS** (Note 2)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 10\text{ mA}$	2.04	2.9	4.4	V
Recommended Gate Voltage	$V_{GOP}$		-3	-	+18	V
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 18\text{ V}, I_D = 20\text{ A}, T_J = 25^\circ\text{C}$	-	40	54	m $\Omega$
		$V_{GS} = 18\text{ V}, I_D = 20\text{ A}, T_J = 175^\circ\text{C}$ (Note 6)	-	80	-	
Forward Transconductance	$g_{FS}$	$V_{DS} = 10\text{ V}, I_D = 20\text{ A}$ (Note 6)	-	16	-	S

**CHARGES, CAPACITANCES & GATE RESISTANCE**

Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V}, f = 1\text{ MHz}, V_{DS} = 800\text{ V}$ (Note 6)	-	1700	-	pF
Output Capacitance	$C_{OSS}$		-	80	-	
Reverse Transfer Capacitance	$C_{RSS}$		-	7	-	
Total Gate Charge	$Q_G(TOT)$	$V_{GS} = -3/18\text{ V}, V_{DS} = 800\text{ V}, I_D = 20\text{ A}$ (Note 6)	-	75	-	nC
Threshold Gate Charge	$Q_G(TH)$		-	4.4	-	
Gate-to-Source Charge	$Q_{GS}$		-	14	-	
Gate-to-Drain Charge	$Q_{GD}$		-	22	-	
Gate-Resistance	$R_G$	$f = 1\text{ MHz}$	-	3.8	-	$\Omega$

**SWITCHING CHARACTERISTICS**

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = -3/18\text{ V}, V_{DS} = 800\text{ V}, I_D = 20\text{ A}, R_G = 4.7\text{ }\Omega$ Inductive load (Notes 5, 6)	-	12	-	ns
Rise Time	$t_r$		-	15	-	
Turn-Off Delay Time	$t_{d(OFF)}$		-	35	-	
Fall Time	$t_f$		-	10	-	
Turn-On Switching Loss	$E_{ON}$		-	182	-	$\mu\text{J}$
Turn-Off Switching Loss	$E_{OFF}$		-	66	-	
Total Switching Loss	$E_{tot}$		-	248	-	

**SOURCE-DRAIN DIODE CHARACTERISTICS**

Continuous Source-Drain Diode Forward Current	$I_{SD}$	$V_{GS} = -3\text{ V}, T_C = 25^\circ\text{C}$ (Note 6)	-	-	45	A
Pulsed Source-Drain Diode Forward Current (Note 2)	$I_{SDM}$		-	-	134	
Forward Diode Voltage	$V_{SD}$	$V_{GS} = -3\text{ V}, I_{SD} = 20\text{ A}, T_J = 25^\circ\text{C}$	-	4.5	-	V

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**Table 2. ELECTRICAL CHARACTERISTICS** ( $T_J = 25^\circ\text{C}$  unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>SOURCE-DRAIN DIODE CHARACTERISTICS</b>						
Reverse Recovery Time	$t_{RR}$	$V_{GS} = -3/18\text{ V}$ , $I_{SD} = 20\text{ A}$ , $di_S/dt = 1000\text{ A}/\mu\text{s}$ , $V_{DS} = 800\text{ V}$ (Note 6)	-	16.8	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	82	-	nC
Reverse Recovery Energy	$E_{REC}$		-	7.9	-	$\mu\text{J}$
Peak Reverse Recovery Current	$I_{RRM}$		-	9.8	-	A
Charge Time	$T_A$		-	9.6	-	ns
Discharge Time	$T_B$		-	7.2	-	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5.  $E_{ON}/E_{OFF}$  result is with body diode.

6. Defined by design, not subject to production test.

# NTH4L040N120M3S

## TYPICAL CHARACTERISTICS

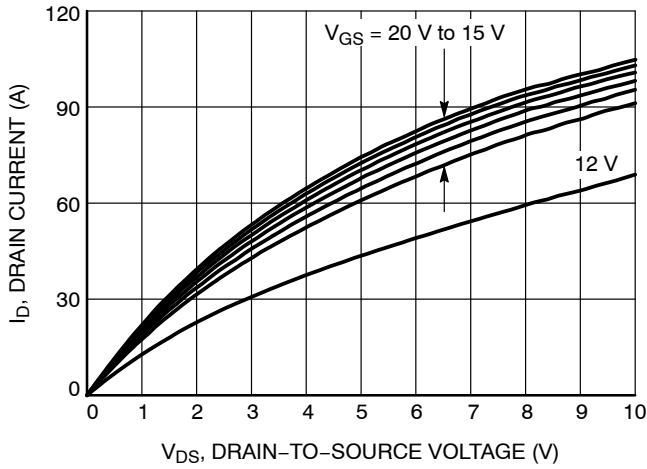


Figure 1. On-Region Characteristics

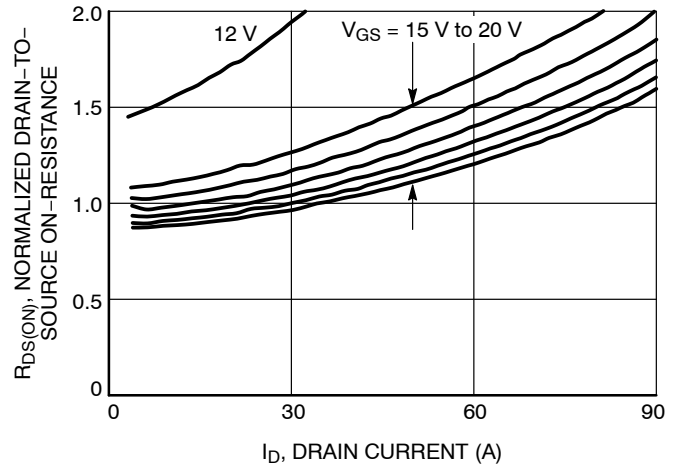


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

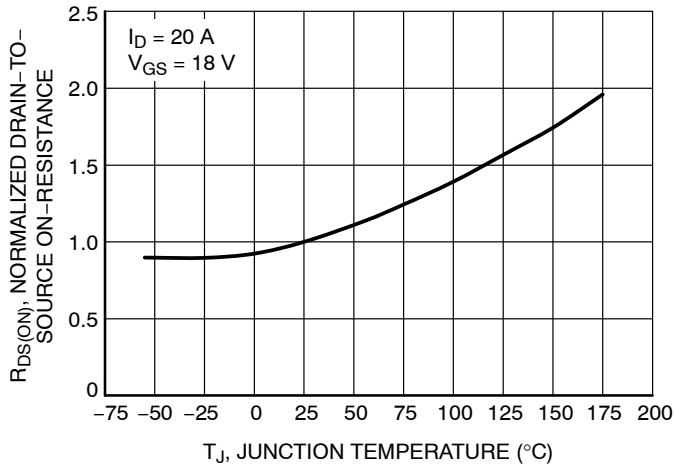


Figure 3. On-Resistance Variation with Temperature

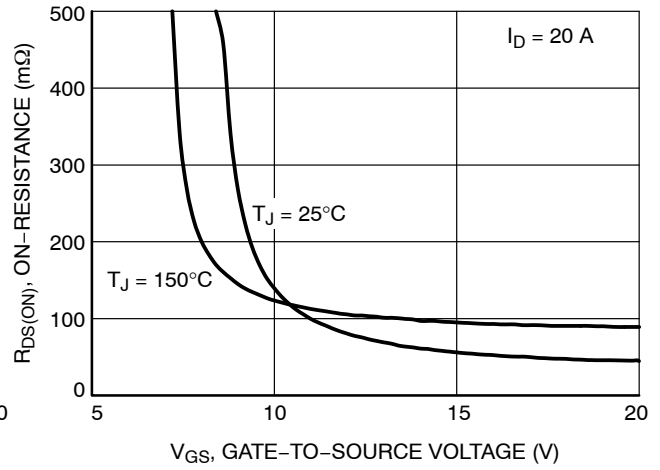


Figure 4. On-Resistance vs. Gate-to-Source Voltage

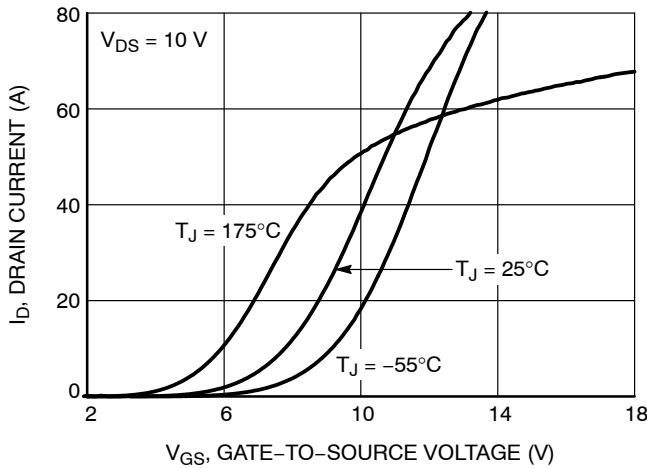


Figure 5. Transfer Characteristics

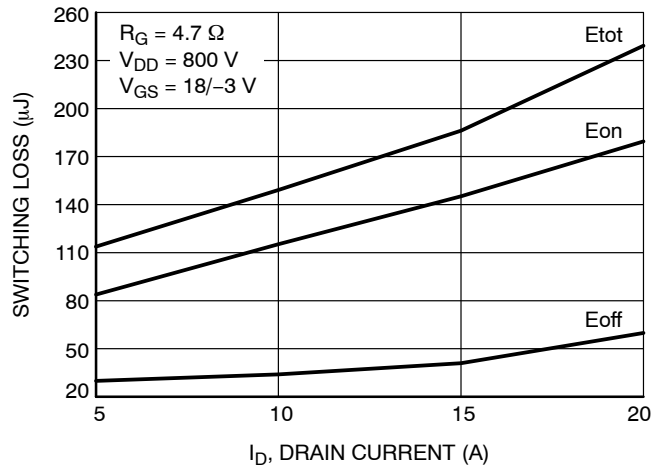
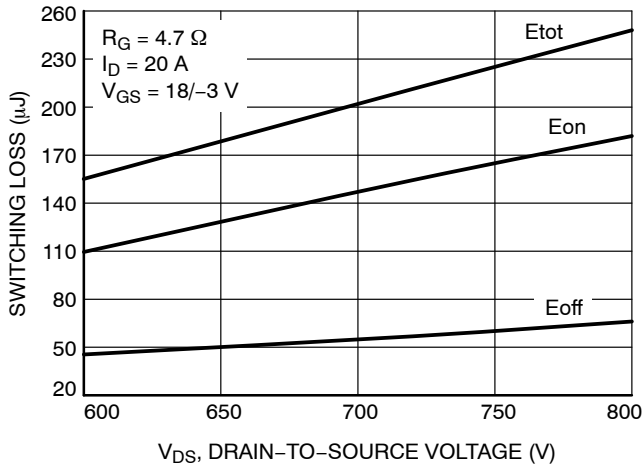


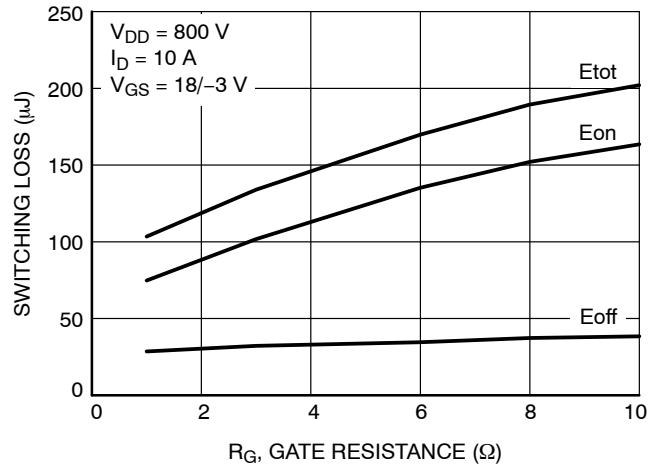
Figure 6. Switching Loss vs. Drain Current

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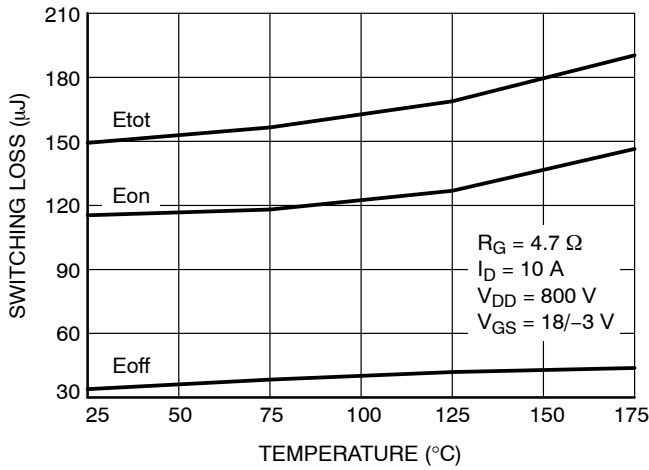
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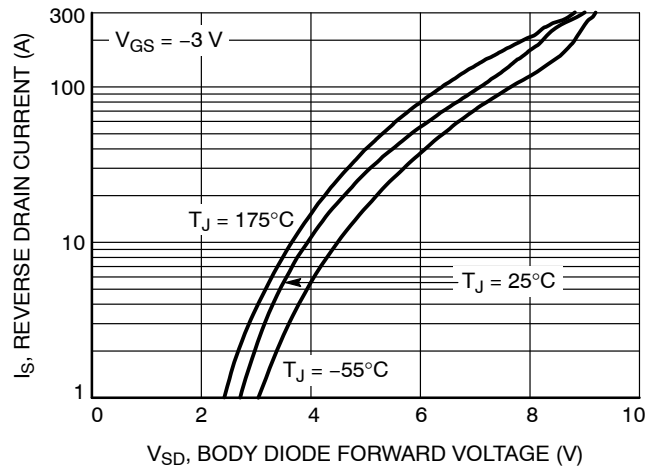
**Figure 7. Switching Loss vs. Drain-to-Source Voltage**



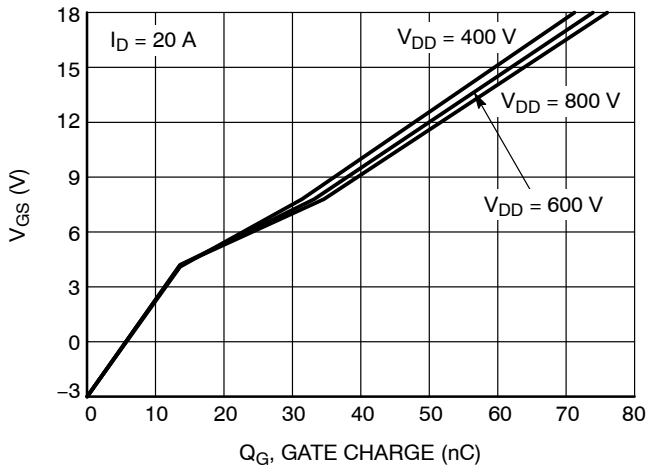
**Figure 8. Switching Loss vs. Gate Resistance**



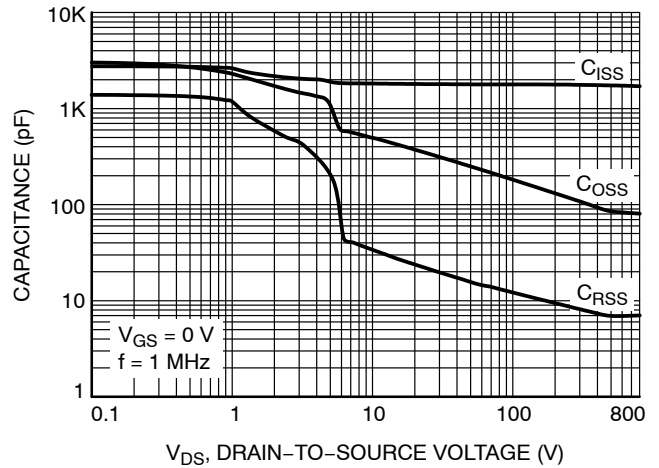
**Figure 9. Switching Loss vs. Temperature**



**Figure 10. Reverse Drain Current vs. Body Diode Forward Voltage**



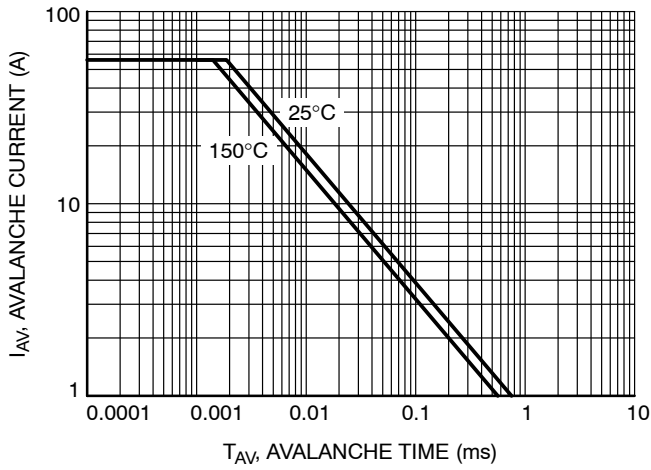
**Figure 11. Gate-to-Source Voltage vs. Total Charge**



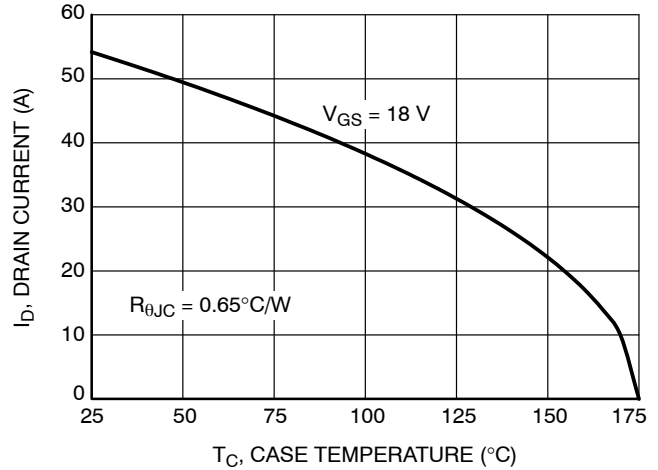
**Figure 12. Capacitance vs. Drain-to-Source Voltage**

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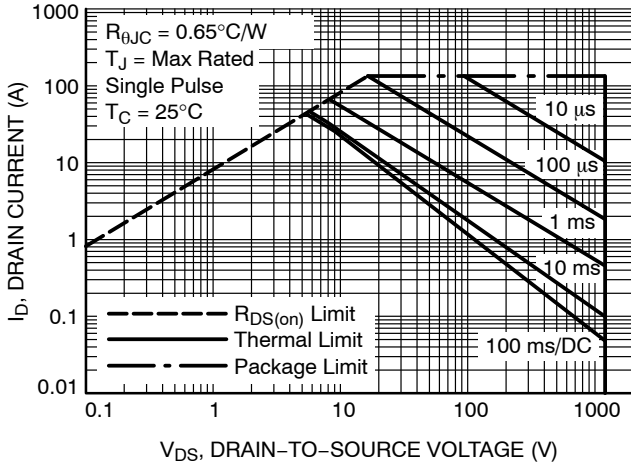
## TYPICAL CHARACTERISTICS



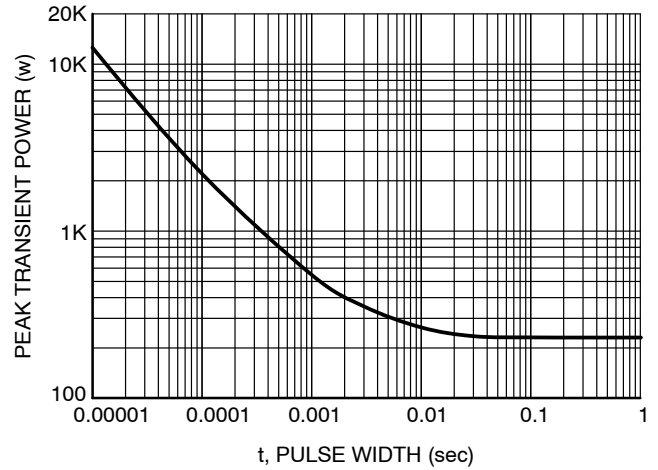
**Figure 13. Unclamped Inductive Switching Capability**



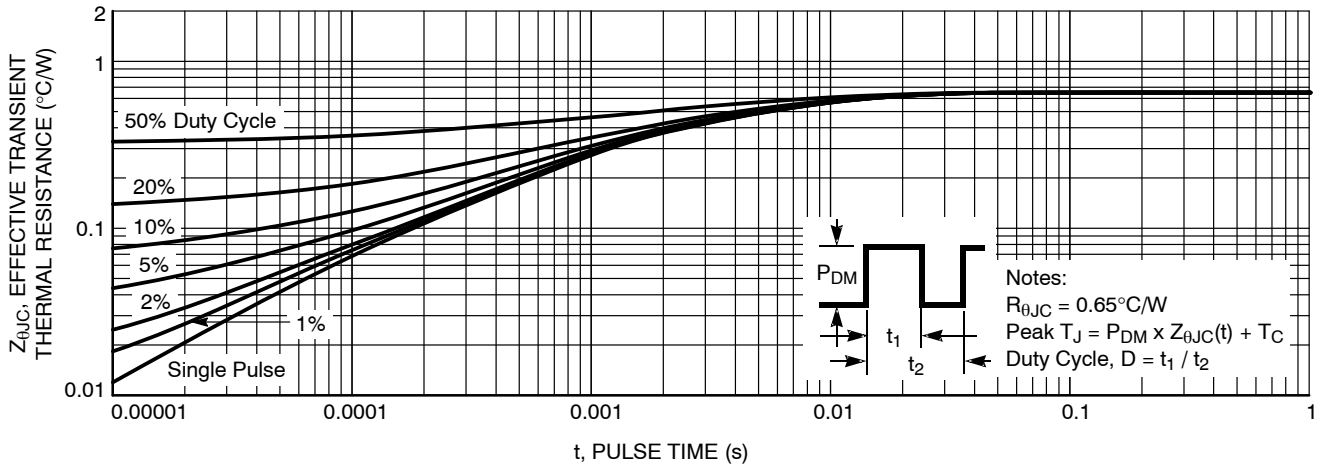
**Figure 14. Maximum Continuous Drain Current vs. Case Temperature**



**Figure 15. Safe Operating Area**



**Figure 16. Single Pulse Maximum Power Dissipation**



**Figure 17. Junction-to-Case Transient Thermal Response**

# MECHANICAL CASE OUTLINE

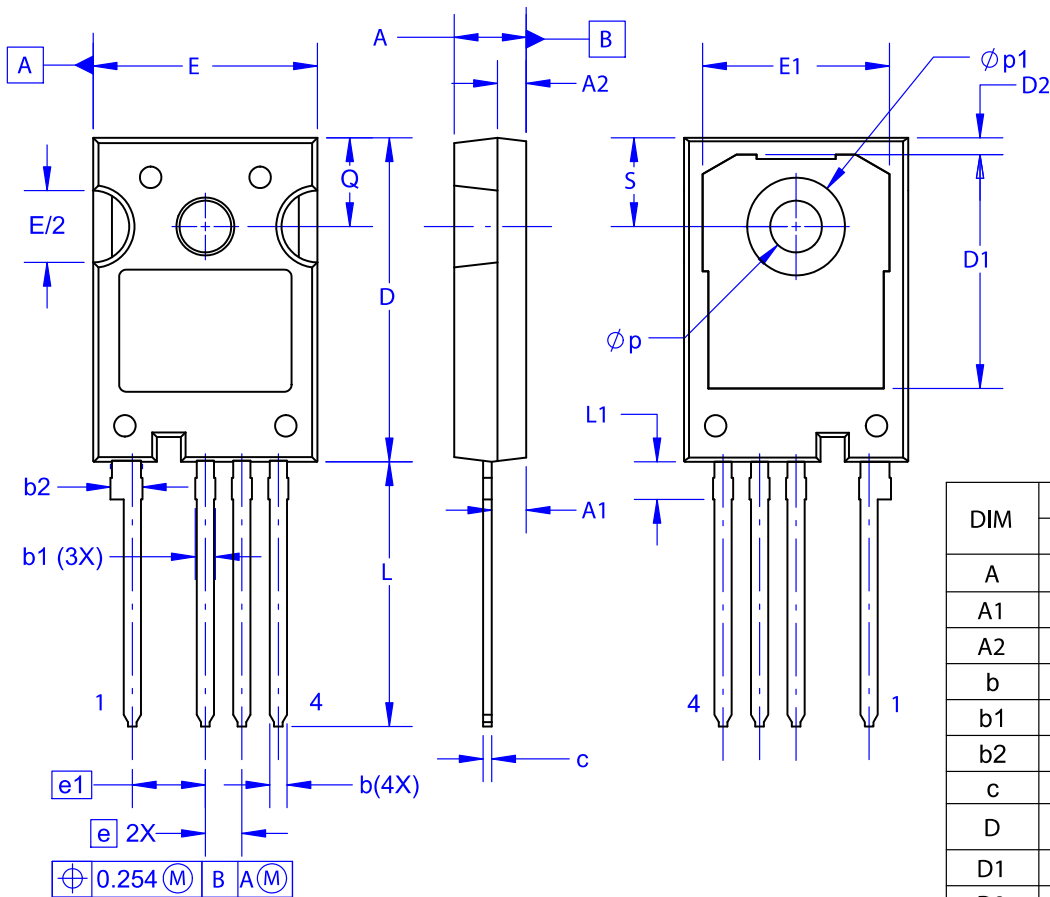
## PACKAGE DIMENSIONS

ON Semiconductor®



TO-247-4LD  
CASE 340CJ  
ISSUE A

DATE 16 SEP 2019



DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.10	2.40	2.70
A2	1.80	2.00	2.20
b	1.07	1.20	1.33
b1	1.20	1.40	1.60
b2	2.02	2.22	2.42
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.25	16.50
D2	0.97	1.17	1.37
e	2.54 BSC		
e1	5.08 BSC		
E	15.40	15.60	15.80
E1	12.80	13.00	13.20
E/2	4.80	5.00	5.20
L	18.22	18.42	18.62
L1	2.42	2.62	2.82
p	3.40	3.60	3.80
p1	6.60	6.80	7.00
Q	5.97	6.17	6.37
S	5.97	6.17	6.37

NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
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